

Search Notes

Application No.

10/617,736

Examiner

Nguyen N Hanh

Applicant(s)

PARK ET AL.

Art Unit

2834

SEARCHED

Class	Subclass	Date	Examiner
310	216	10/8/2004	HN
310	217	10/8/2004	HN
310	218	10/8/2004	HN
310	179	10/8/2004	HN
310	254	10/8/2004	HN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner